

## PART NUMBER 74S288AV-ROCS

# Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All re-creations are done with the approval of the Original Component Manufacturer. (OCM)

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

## **Quality Overview**

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-38535
  - Class Q Military
  - Class V Space Level

Qualified Suppliers List of Distributors (QSLD)

 Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OCM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.



## DM54S288, DM74S288

## 256-Bit TTL PROM

The Schottky memory is organized in the popular 32 words by 8 bits configuration. A memory enable input is provided to control the output states. When the devices is enabled, the outputs represent the contents of the selected word. When disabled, the 8 outputs go to the "OFF" or high impedance state.

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## DM54/74S288 (32 x 8) 256-Bit TTL PROM

### **General Description**

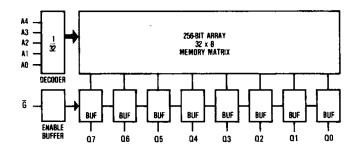
This Schottky memory is organized in the popular 32 words by 8 bits configuration. A memory enable input is provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 8 outputs go to the "OFF" or high impedance state.

PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

#### **Features**

- Advanced titanium-tungsten (Ti-W) fuses
- Schottky-clamped for high speed Address access down to—25 ns max Enable access—20 ns max Enable recovery—20 ns max
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE™ programming
- TRI-STATE® Outputs

### **Block Diagram**



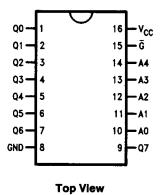
TL/D/8360-1

#### **Pin Names**

A0-A4	Addresses
G	Enable
GND	Ground
Q0-Q7	Outputs
V <sub>CC</sub>	Power Supply

## **Connection Diagrams**

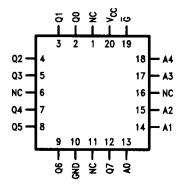
#### **Duai-in-Line Package**



TL/D/8360-2

Order Number DM54/74S288J, 288AJ or DM74S288N, 288AN See NS Package Number J16A or N16A

#### Plastic Leaded Chip Carrier (PLCC)



TL/D/8360-7 **Top View** 

Order Number DM74S288V or 288AV See NS Package Number V20A

## **Ordering Information**

#### Commercial Temp Range (0°C to +70°C)

Parameter/Order Number	Max Access Time (ns)
DM74S288N	35
DM74S288J	35
DM74S288V	35
DM74S288AN	25
DM74S288AJ	25
DM74S288AV	25

#### Military Temp Range (-55°C to +125°C)

Parameter/Order Number	Max Access Time (ns)
DM54S288J	45
DM54S288AJ	35

## Absolute Maximum Ratings (Note 1)

if Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage (Note 2)	-0.5V to $+7.0V$
Input Voltage (Note 2)	-1.2V to $+5.5V$
Output Voltage (Note 2)	-0.5V to $+5.5V$
Storage Temperature	-65°C to +150°C
Lead Temperature (Soldering, 10 sec.)	300°C

Operating Conditions           Min         Max         Units           Supply Voltage (V <sub>CC</sub> )         5.50         V           Military         4.50         5.50         V           Commercial         4.75         5.25         V           Ambient Temperature (T <sub>A</sub> )         -55         + 125         °C					
-	Min	Max	Units		
Supply Voltage (V <sub>CC</sub> )					
Military	4.50	5.50	٧		
Commercial	4.75	5.25	V		
Ambient Temperature (TA)					
Military	-55	+ 125	°C		
Commercial	0	+70	°C		
Logical "0" Input Voltage	0	0.8	٧		
Logical "1" Input Voltage	2.0	5.5	٧		

## **DC Electrical Characteristics** (Note 3)

ESD rating to be determined

Symbol	Parameter	Conditions	DM54S288			DM74S288			Units
	T di dillotoi	Conditions	Min	Тур	Max	Min	Тур	Max	Units
l <sub>IL</sub>	Input Load Current	$V_{CC} = Max, V_{IN} = 0.45V$		-80	-250		-80	-250	μΑ
I <sub>IH</sub>	Input Leakage Current	$V_{CC} = Max, V_{IN} = 2.7V$			25			25	μΑ
		$V_{CC} = Max, V_{IN} = 5.5V$			1.0			1.0	mA
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 16 mA		0.35	0.50		0.35	0.45	V
V <sub>IL</sub> (Note 4)	Low Level Input Voltage				0.80			0.80	V
V <sub>IH</sub> (Note 4)	High Level Input Voltage		2.0			2.0			٧
V <sub>C</sub>	Input Clamp Voltage	$V_{CC}$ = Min, $I_{IN}$ = $-18$ mA		-0.8	-1.2		-0.8	-1.2	V
C <sub>I</sub>	Input Capacitance	V <sub>CC</sub> = 5.0, V <sub>IN</sub> = 2.0V T <sub>A</sub> = 25°C, 1 MHz		4.0			4.0		pF
Co	Output Capacitance	$V_{CC} = 5.0V$ , $V_{O} = 2.0V$ $T_{A} = 25^{\circ}C$ , 1 MHz, Outputs Off		6.0			6.0		pF
lcc	Power Supply Current	V <sub>CC</sub> = Max, Input Grounded All Outputs Open		70	110		70	110	mA
los	Short Circuit Output Current	V <sub>O</sub> = 0V, V <sub>CC</sub> = Max (Note 5)	-20		-70	-20		-70	mA
loz	Output Leakage	$V_{CC} = Max, V_{O} = 0.45V \text{ to } 2.4V$			+ 50			+ 50	μΑ
	(TRI-STATE)	Chip Disabled			-50			-50	μА
V <sub>OH</sub>	Output Voltage High	I <sub>OH</sub> = -2.0 mA	2.4	3.2					٧
		I <sub>OH</sub> = -6.5 mA				2.4	3.2		V

Note 1: Absolute maximum ratings are those values beyond which the device may be permanently damaged. They do not mean that the device may be operated at these values.

Note 2: These limits do not apply during programming. For the programming ratings, refer to the programming instructions.

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25^{\circ}C$ .

Note 4: These are absolute voltages with respect to pin 8 on the device and include all overshoots due to system and/or tester noise. Do not attempt to test these values without suitable equipment.

Note 5: During IOS measurement, only one output at a time should be grounded. Permanent damage may otherwise result.

**COMMERCIAL TEMPERATURE RANGE (0°C to +70°C)** 

Symbol	Parameter	JEDEC	DM74S288			DM74S288A			Units
	- didinotoi	Symbol	Min	Тур	Max	Min	Тур	Max	
TAA	Address Access Time	TAVQV		22	35		17	25	ns
TEA	Enable Access Time	TEVQV		15	20		15	20	ns
TER	Enable Recovery Time	TEXQX	ļ	15	25		15	20	ns
TZX	Output Enable Time	TEVQX		15	25		15	20	ns
TXZ	Output Disable Time	TEXQZ		15	25		15	20	ns

#### MILITARY TEMPERATURE RANGE (-55°C to +125°C)

Symbol JEDEC Symbol Parameter	Parameter	DM54S288			DM54S288A			Units	
	Min	Тур	Max	Min	Тур	Max	Onits		
TAA	TAVQV	Address Access Time		22	45		17	35	ns
TEA	TEVQV	Enable Access Time		15	30		15	30	ns
TER	TEXQX	Enable Recovery Time		15	35		15	30	ns
TZX	TEVQZ	Output Enable Time		15	30		15	30	ns
TXZ	TEXQZ	Output Disable Time		15	35		15	30	ns

## **Functional Description**

#### **TESTABILITY**

The Schottky PROM die includes extra rows and columns of fusable links for testing the programmability of each chip. These test fuses are placed at the worst-case chip locations to provide the highest possible confidence in the programming tests in the final product. A ROM pattern is also permanently fixed in the additional circuitry and coded to provide a parity check of input address levels. These and other test circuits are used to test for correct operation of the row and column-select circuits and functionality of input and enable gates. All test circuits are available at both wafer and assembled device levels to allow 100% functional and parametric testing at every stage of the test flow.

#### RELIABILITY

As with all National products, the Ti-W PROMs are subjected to an on-going reliability evaluation by the Reliability Assurance Department. These evaluations employ accelerated life tests, including dynamic high-temperature operating life, temperature-humidity life, temperature cycling, and thermal shock. To date, nearly 7.4 million Schottky Ti-W PROM device hours have been logged, with samples in Epoxy B molded DIP (N-package), PLCC (V-package) and CERDIP (J-package). Device performance in all package configurations is excellent.

#### **TITANIUM-TUNGSTEN FUSES**

National's Programmable Read-Only Memories (PROMs) feature titanium-tungsten (Ti-W) fuse links designed to program efficiently with only 10.5V applied. The high performance and reliability of these PROMs are the result of fabrication by a Schottky bipolar process, of which the titanium-tungsten metalization is an integral part, and the use of an on-chip programming circuit.

A major advantage of the titanium-tungsten fuse technology is the low programming voltage of the fuse links. At 10.5V, this virtually eliminates the need for guard-ring devices and wide spacings required for other fuse technologies. Care is taken, however, to minimize voltage drops across the die and to reduce parasitics. The device is designed to ensure that worst-case fuse operating current is low enough for reliable long-term operation. The Darlington programming circuit is liberally designed to insure adequate power density for blowing the fuse links. The complete circuit design is optimized to provide high performance over the entire operating ranges of  $V_{\rm CC}$  and temperature.